

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/721,941	<b>Applicant(s)/Patent under Reexamination</b> ASCARRUNZ ET AL.
<b>Examiner</b> Henry K. Choe	<b>Art Unit</b> 2817	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner